

N-Channel Enhancement Mode Power MOSFET

Description

The MSF6N60 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220F package is universally preferred for all commercial-industrial applications

Features

- · Low On Resistance
- · Simple Drive Requirement
- · Low Gate Charge
- · Fast Switching Characteristic
- RoHS compliant package

Application

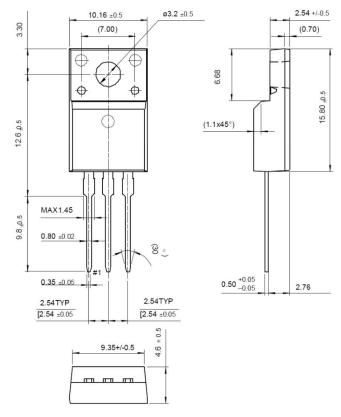
- Open Framed Power Supply
- Adapter
- STB

Packing & Order Information

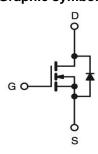
50/Tube; 1,000/Box



RoHS COMPLIANT



Graphic symbol



MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Unit		
V_{DSS}	Drain-Source Voltage	600	V		
V_{GS}	Gate-Source Voltage	±30	V		
I _D	Drain Current -Continuous (TC=25°C)	4.5	А		
	Drain Current -Continuous (TC=100°C)	2.6	Α		
I _{DM}	Drain Current Pulsed	18	Α		
I _{AR}	Avalanche Current	4.5	А		
E _{AS}	Single Pulsed Avalanche Energy	58.6	mJ		
E _{AR}	Repetitive Avalanche Energy	10	mJ		
dv/dt	Peak Diode Recovery dv/dt	4.5	V/ns		



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Absolute Maximum Ratings						
Symbol	Parameter	Value	Unit			
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C			
TPKG	Maximum Temperature for Soldering @ Package Body for 10 seconds	260	°C			
P _D	Total Power Dissipation (TC=25°C)	33	W			
	Derating Factor above 25 °C	0.26	W/°C			
T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C			
T _J	Storage Temperature	150	°C			

Notes;

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} =4.5A, V_{DD} =50V, L=7mH, V_{G} =10V, Starting T_{J} =25°C
- 3. I_{SD} \leq 4.5A, di/dt \leq 100A/ μ s,V_{DD} \leq BV_{DSS}, Starting T_J=25°C

Thermal Characteristics						
Symbol	Symbol Parameter Max.					
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case	3.75	°C/W			
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	C/VV			

Static Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu A$	600			V
ΔBV_{DSS}	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C		0.6		V/°C
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600 V , V _{GS} = 0 V V _{DS} = 480 V , T _C = 125°C			1 10	μA
I _{GSS}	Gate-Body Leakage Forward	V _{GS} = ±30			±100	nA
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10 V,I _D = 3.0 A		1.8	2.3	Ω

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
$t_{d(on)}$	Turn-On Time			9.6		ns
t _r	Turn-On Time	$V_{DS} = 300 \text{ V}, I_{D} = 4.5 \text{ A},$ $R_{G} = 10 \Omega, V_{GS} = 10 \text{ V}$		12.2		ns
t _{d(off)}	Turn-Off Delay Time			22.3		ns
tf	Turn-Off Fall Time			14.8		ns



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Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
Q_g	Total Gate Charge	$V_{DS} = 300 \text{ V}, I_{D} = 4.5 \text{ A},$ $V_{GS} = 10 \text{ V}$		16		nC
Q _{gs}	Gate-Source Charge			3.3		nC
Q_{gd}	Gate-Drain Charge			6.2		nC
C_{ISS}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0MHz		700		pF
Coss	Output Capacitance			86		pF
C _{RSS}	Reverse Transfer Capacitance			20		pF

Source-Drain Diode						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
I_S		$V_D = V_G = 0$			4.5	
I _{SM}		V _S = 1.3 V			18	- A
V _{SD}		$I_{S} = 4.5 \text{ A}$, $V_{GS} = 0 \text{ V}$			1.5	V
t _{rr}		$I_F = 4.5 \text{ A}, V_{GS} = 0 \text{ V}$		320		ns
Q _{rr}		diF/dt=100A/µs		2.7		μC

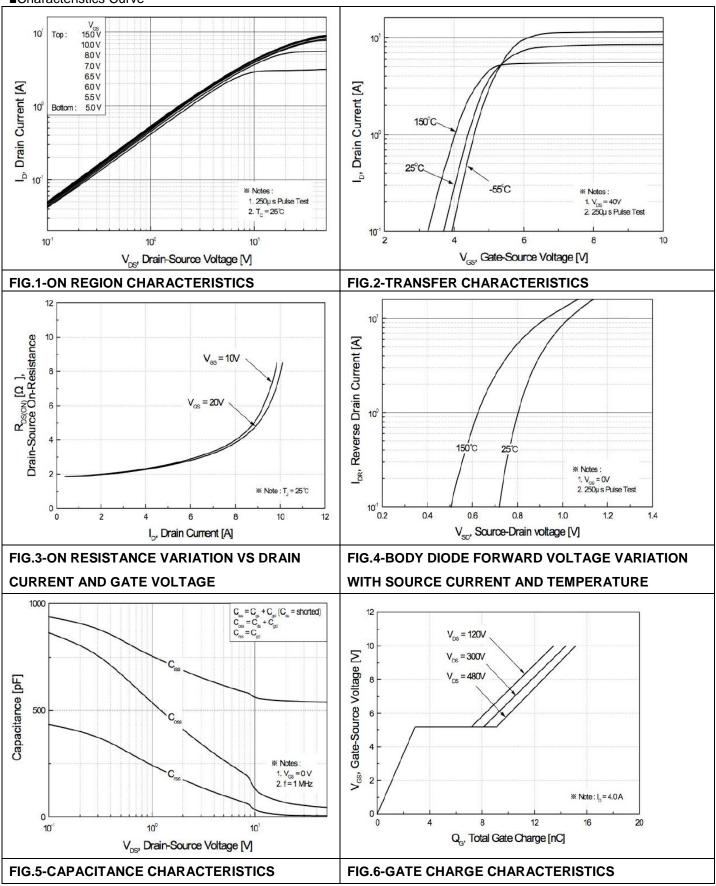
Notes;

1. Pulse Test: Pulse Width ≦ 300µs, Duty Cycle≦ 2%



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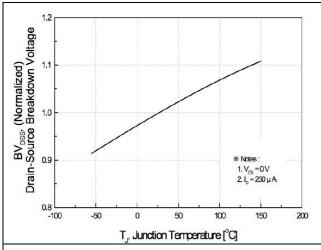
■Characteristics Curve





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■Characteristics Curve



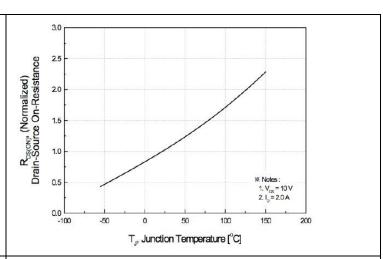


FIG.7-BREAKDOWN VOLTAGE VARIATION VS TEMPERATURE

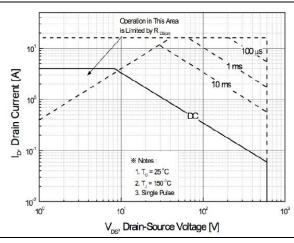


FIG.8-ON-RESISTANCE VARIATION VS TEMPERATURE

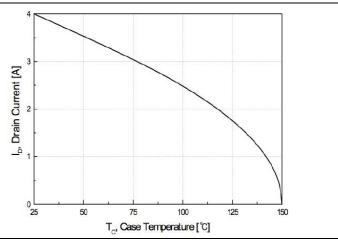
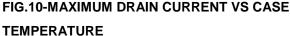


FIG.9-MAXIMUM SAFE OPERATING AREA



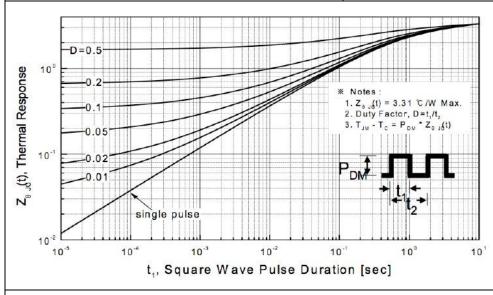


FIG.11-TRANSIENT THERMAL RESPONSE CURVE



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